

**Search Notes**

Application/Control No.

10/812,040

Examiner

Felix J. Nepveux

Applicant(s)/Patent under  
Reexamination

HEER ET AL.

Art Unit

1617

**SEARCHED**

Class	Subclass	Date	Examiner
424	405	8/7/2005	<i>[Signature]</i>
514	241	8/7/2005	<i>[Signature]</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Structure Search	8/1/2005	<i>[Signature]</i>
Inventor Search	8/7/2005	<i>[Signature]</i>